



First Combined Scattering and Fluorescence Scanning Transmission Microscopy at the NanoMAX Beam Line at MAX IV

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First Combined Scattering and Fluorescence Scanning

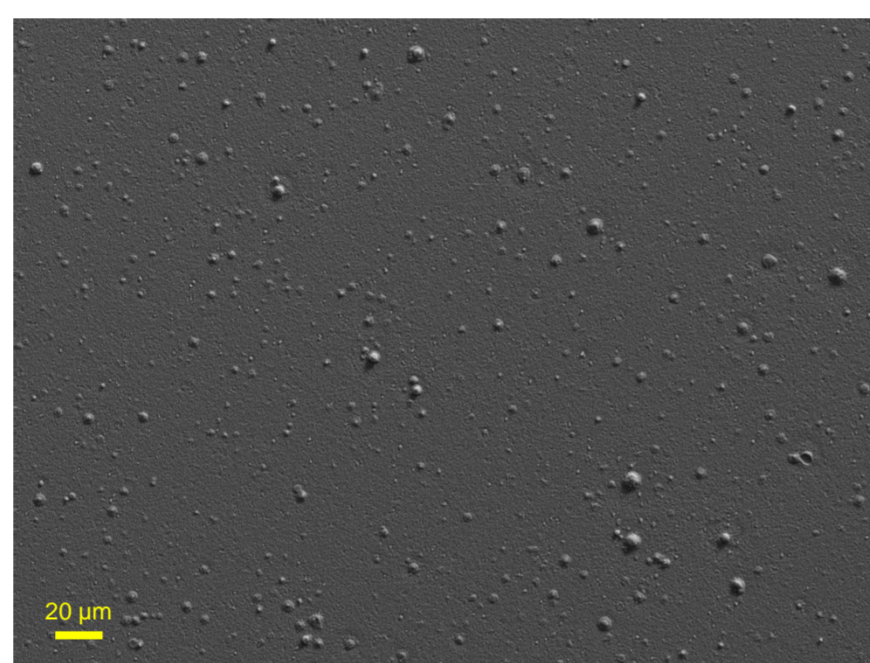
Transmission Microscopy at the NanoMAX Beam Line at MAX IV

Giovanni Fevola, Tiago Ramos, Mariana M. Lucas, Christian Rein, Jens W. Andreasen

Overview & Motivation

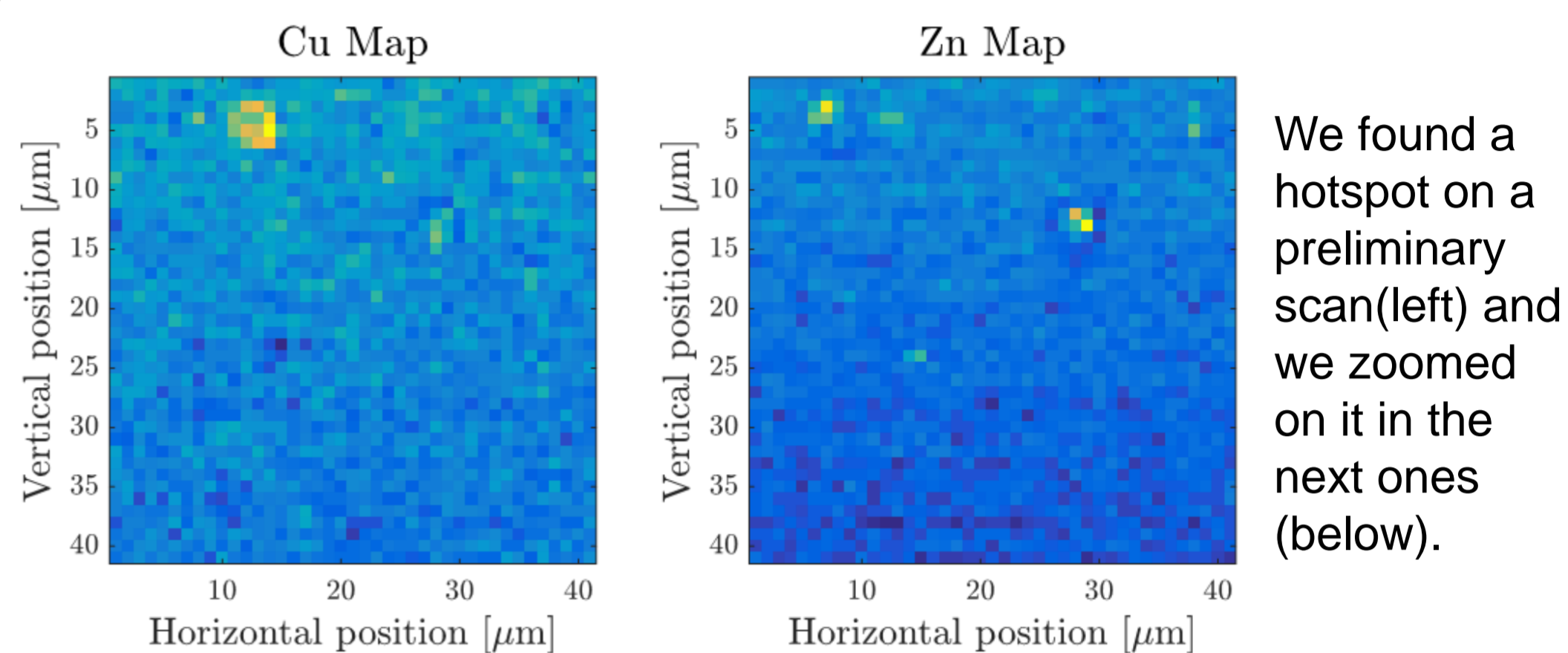
Materials with the approximate stoichiometry $\text{Cu}_2\text{ZnSnS}_4$ with the crystal structure of the mineral kesterite are currently being investigated as promising materials for thin film solar cell fabrication. We acquired fluorescence and scattering maps of a pulsed layer deposited (PLD) kesterite sample at the NanoMAX beam line at MAX IV, presently in commissioning.

This (right) is what the surface looks like in the electron microscope (SEM), showing some grains due to inhomogeneity of the PLD process.

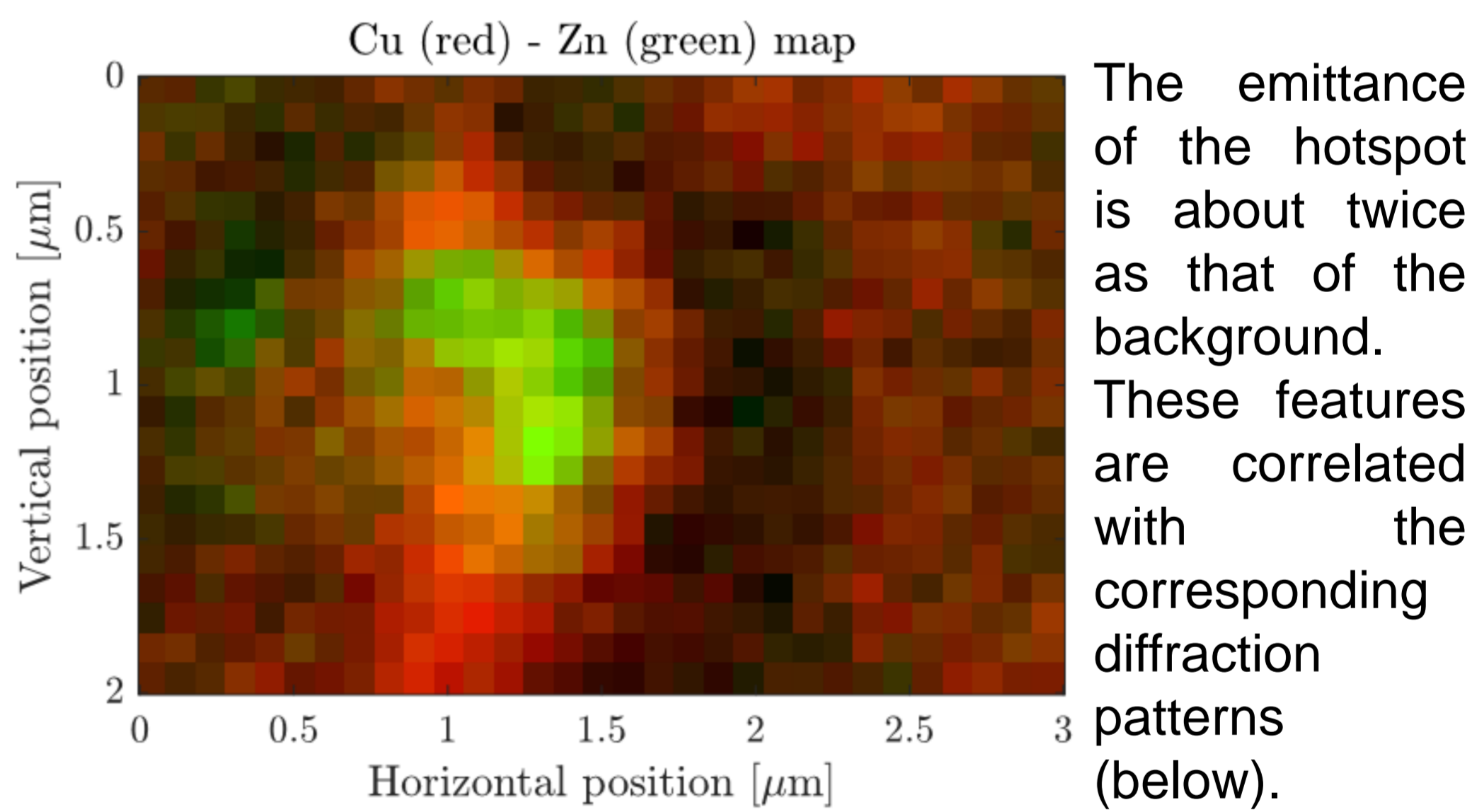
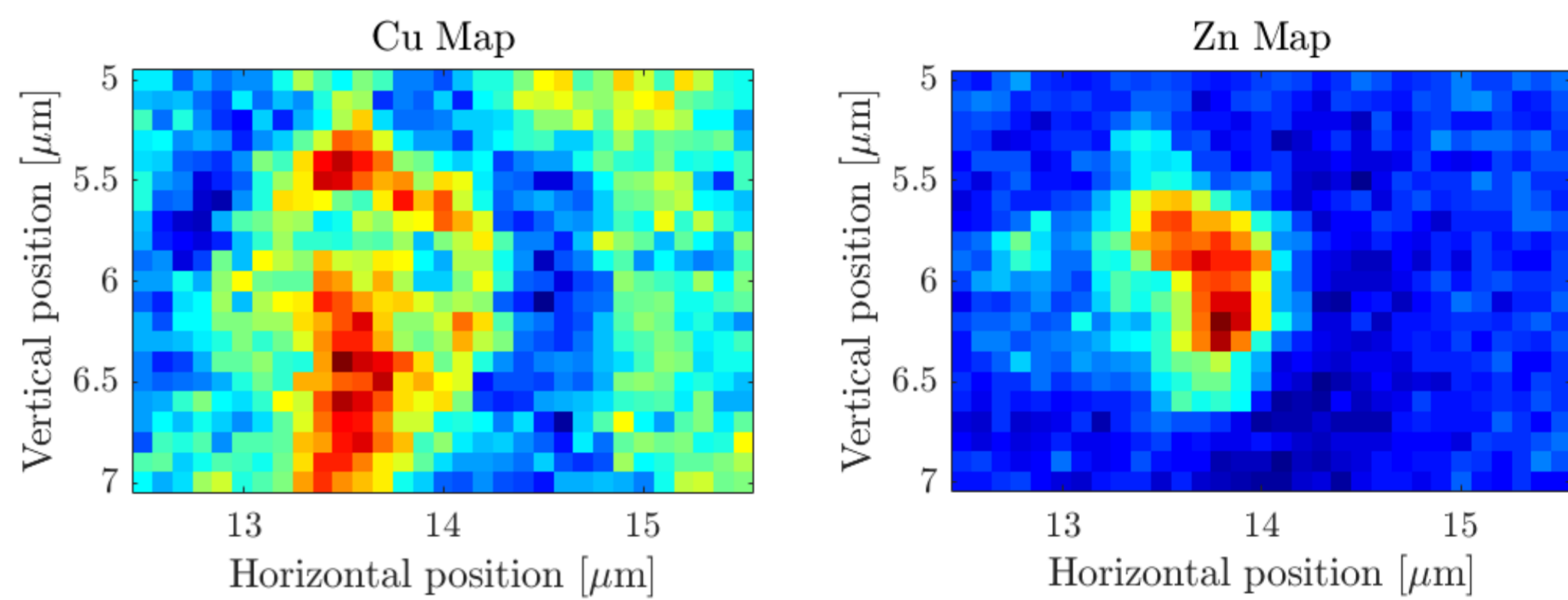


The NanoMAX beam line is still under development, and this experiment was also part of the beam line commissioning.

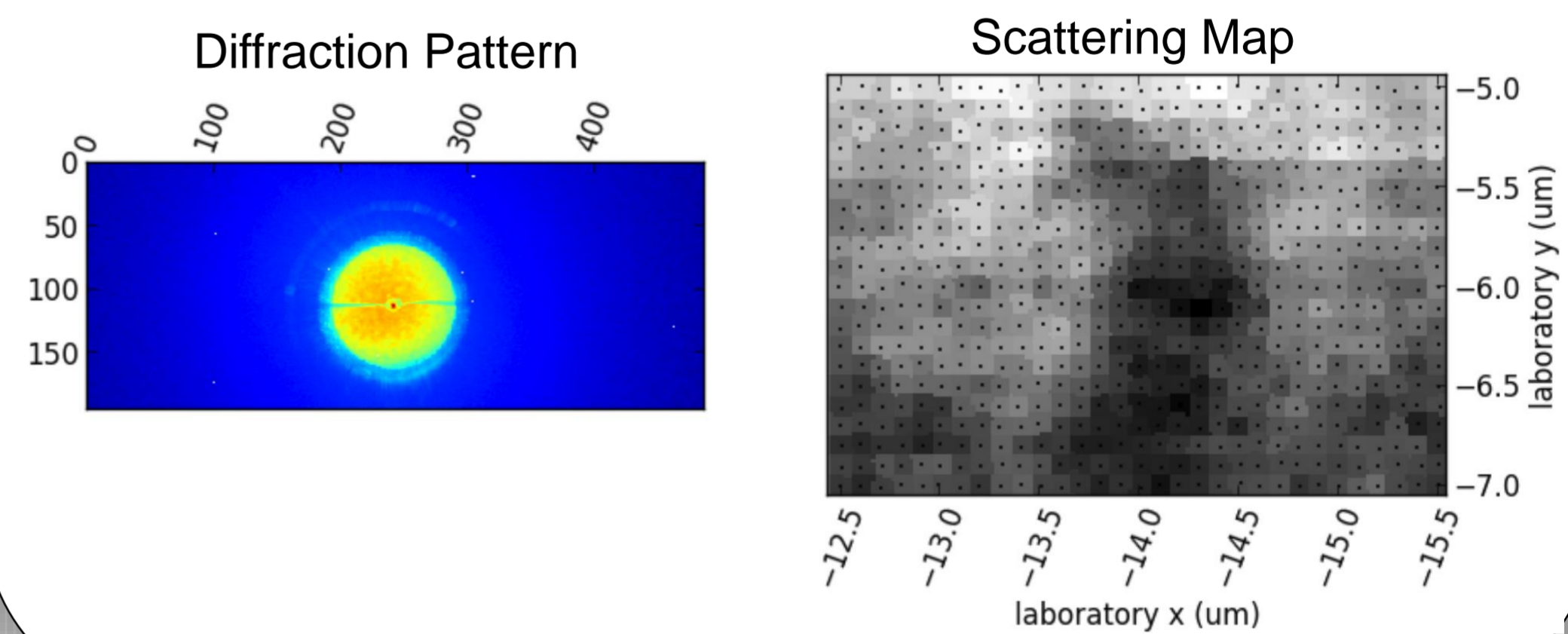
Results



We found a hotspot on a preliminary scan (left) and we zoomed on it in the next ones (below).

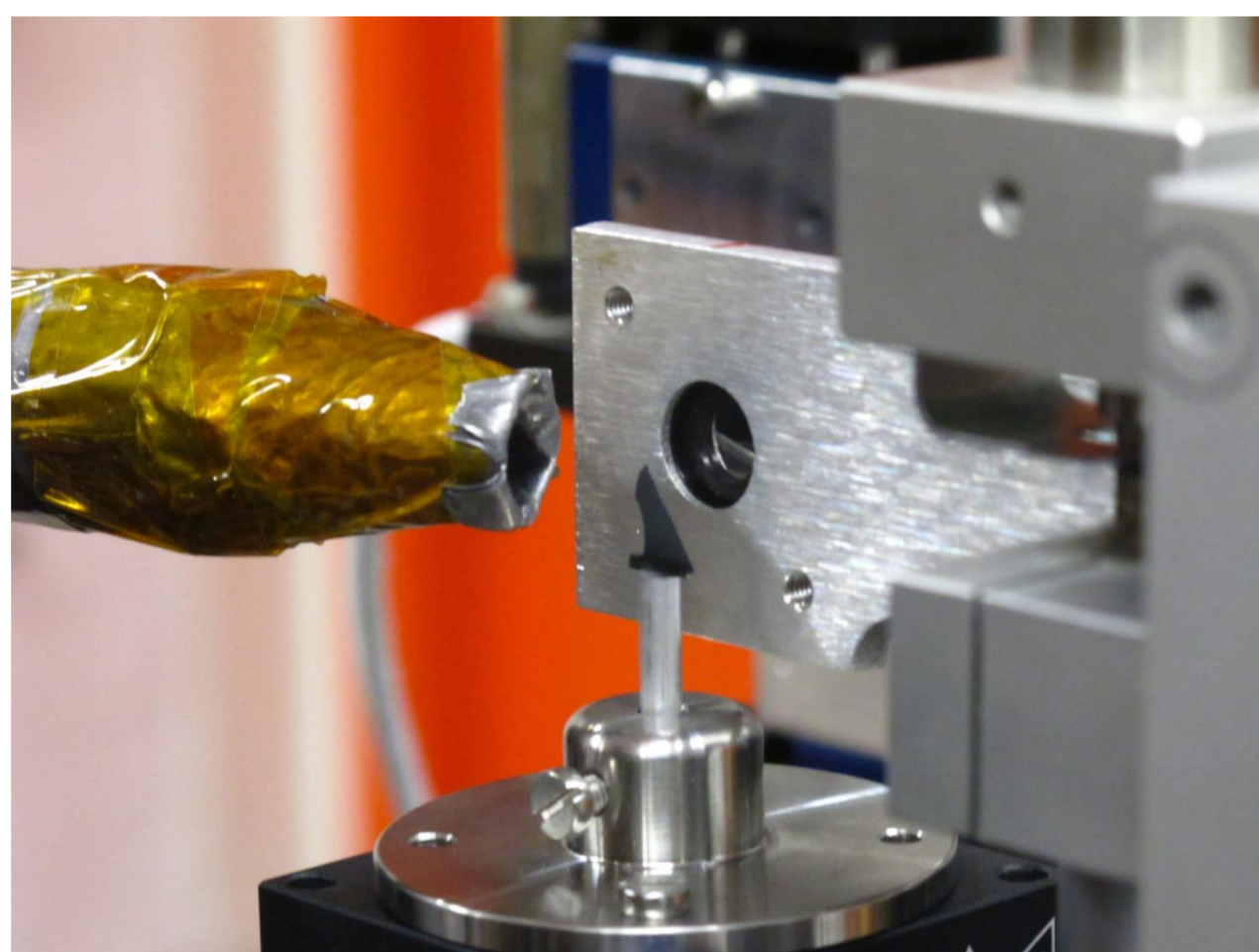


The emittance of the hotspot is about twice as that of the background. These features are correlated with the corresponding diffraction patterns (below).



Experimental Setup & Methods

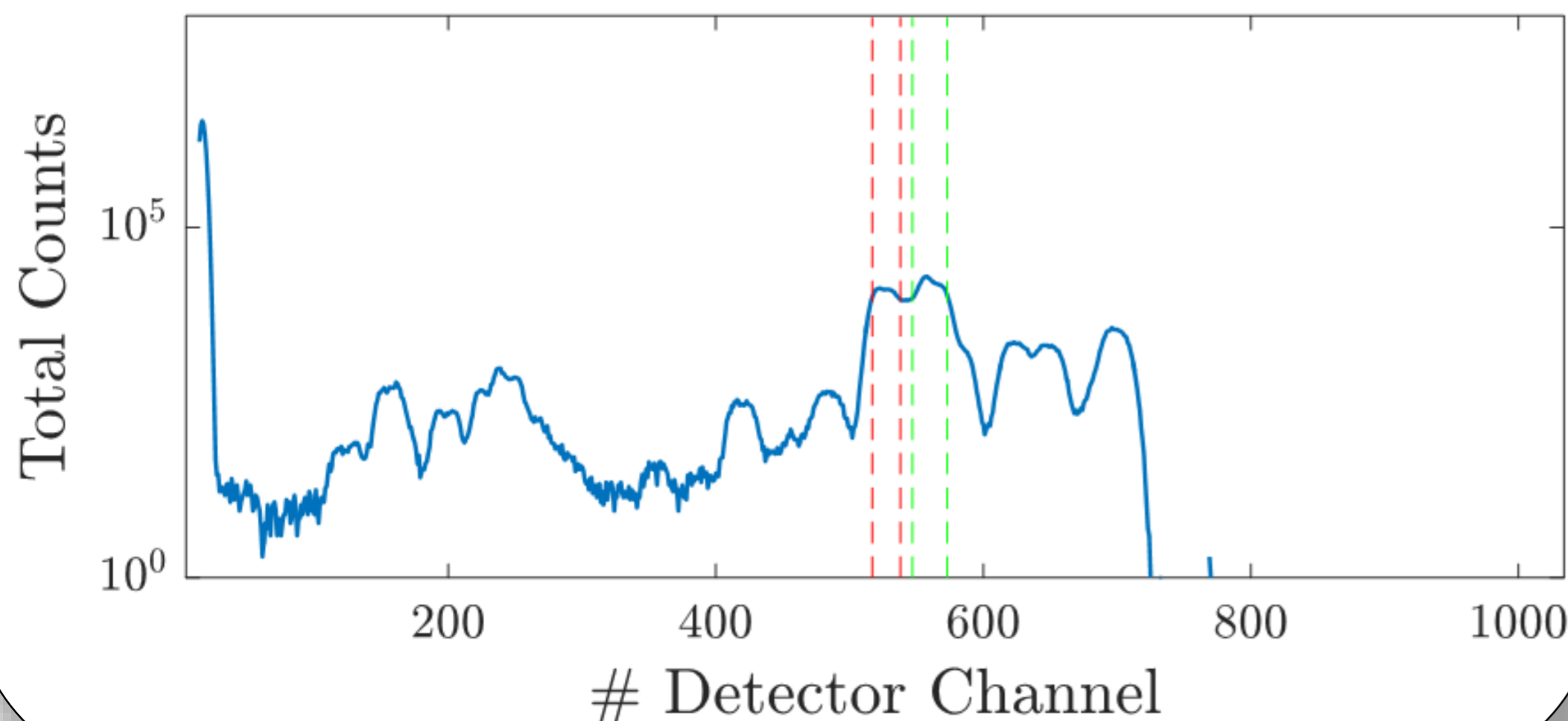
-Fluorescence detector-sample beam relative position



-The forward (small angle) scattering pattern is measured 4.3 m from the sample with a Pilatus detector to verify correlation with the fluorescence map.

-The fluorescence map of an element is obtained by integrating the counts over the element's band.

Scan 21 Sample Spectrum



Acknowledgements

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